UNISONIC TECHNOLOGIES CO., LTD

UTT68N03 POWER MOSFET

68A, 30V N-CHANNEL POWER MOSFET

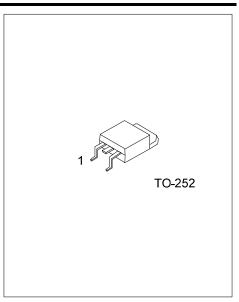
■ DESCRIPTION

The UTC **UTT68N03** is a N-channel mode power MOSFET using UTC's advanced technology to provide customers with a minimum on-state resistance, low gate charge and high switching speed.

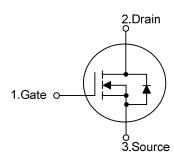
The UTC **UTT68N03** is suitable for high voltage synchronous rectifier and DC/DC converters, etc.

■ FEATURES

- * $R_{DS(ON)}$ < 9.2 m Ω @ V_{GS} =10V, I_D =20A $R_{DS(ON)}$ < 18 m Ω @ V_{GS} =4.5V, I_D =20A
- * High Switching Speed
- * High Cell Density Trench Technology



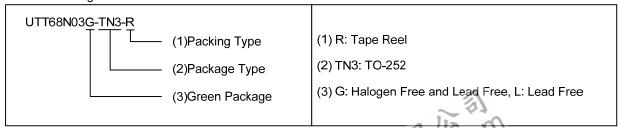
■ SYMBOL



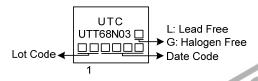
ORDERING INFORMATION

Ordering Number		Doolsone	Pin Assignment			Doolsing	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UTT68N03L-TN3-R	UTT68N03G-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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UTT68N03 Power MOSFET

■ **ABSOLUTE MAXIMUM RATING** (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	30	V
Gate-Source Voltage		V_{GSS}	±20	V
Drain Current	Continuous	I _D	68	Α
	Pulsed (Note 2)	I _{DM}	136	Α
Avalanche Energy (Note 3)	Single Pulsed (Note 3)	E _{AS}	21	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.9	V/nS
Power Dissipation		P _D	50	W
Junction Temperature		T_J	+150	°C
Storage Temperature Range		T _{STG}	-55 ~ + 150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L=0.1mH, I_{AS} =20.5A, V_{DD} =50V, R_G = 25 Ω , Starting T_J = 25 $^{\circ}$ C
- 4. $I_{SD} \le 30A$, $di/dt \le 200A/\mu s$, $V_{DD} \le V_{(BR)DSS}$, $T_J \le 25$ °C

■ THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ_{JA}	110	°C/W	
Junction to Case	θ_{JC}	2.5 (Note)	°C/W	

Note: The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

■ ELECTRICAL CHARACTERISTICS (T_J =25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	I _D =250μA, V _{GS} =0V	30			V		
Drain-Source Leakage Current	I _{DSS}	V _{DS} =68V, V _{GS} =0V			10	μΑ		
Forward	I _{GSS}	V _{GS} =+20V, V _{DS} =0V			+100	nA		
Gate-Source Leakage Current Reverse		V _{GS} =-20V, V _{DS} =0V			-100	nA		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	V _{DS} =V _{GS} , I _D =1mA	8.0		2.0	V		
Static Drain-Source On-State Resistance		V _{GS} =10V, I _D =20A			9.2	mΩ		
Static Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D =20A			18	mΩ		
DYNAMIC PARAMETERS								
Input Capacitance	C _{ISS}			1802		pF		
Output Capacitance	Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		275		pF		
Reverse Transfer Capacitance	C _{RSS}			225		pF		
SWITCHING PARAMETERS								
Total Gate Charge (Note 1)	Q_G	\/ -15\/ \/ -10\/ -1.20		77		nC		
Gate to Source Charge	Q_GS	V_{DS} =15V, V_{GS} =10V, I_{D} =1.3A I_{G} =1mA (Note 1, 2)		7.6		nC		
Gate to Drain Charge	Q_GD	IG-IIIIA (Note 1, 2)		12		nC		
Turn-on Delay Time (Note 1)	t _{D(ON)}			24		ns		
Rise Time	t _R	V_{DS} =15V, V_{GS} =10V, I_{D} =0.5A,		73		ns		
Turn-off Delay Time	t _{D(OFF)}	$R_G = 3\Omega$ (Note 1, 2)		386		ns		
Fall-Time	t _F	3		188		ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Maximum Body-Diode Continuous Current	Is	1 1 1 CO			68	Α		
Maximum Body-Diode Pulsed Current	I _{SM}	18 (80.			136	Α		
Drain-Source Diode Forward Voltage (Note 1)	V_{SD}	I _S =68A, V _{GS} =0V			1.4	V		
Reverse Recovery Time (Note 1)	t _{rr}	1 -60 0 1/1 -0/1 d1/dt-30 0 /::-		118		nS		
Reverse Recovery Charge	Q_{rr}	I_S =68A, V_{GS} =0V, dI/dt=30A/ μ s		191		nC		

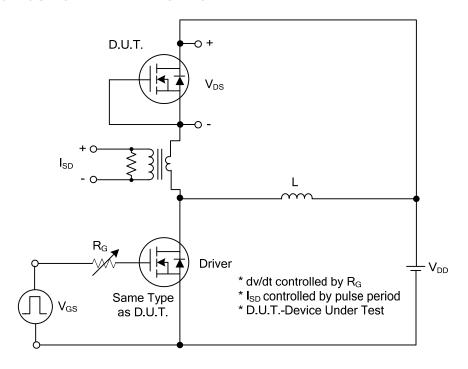
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

2. Essentially independent of operating temperature.

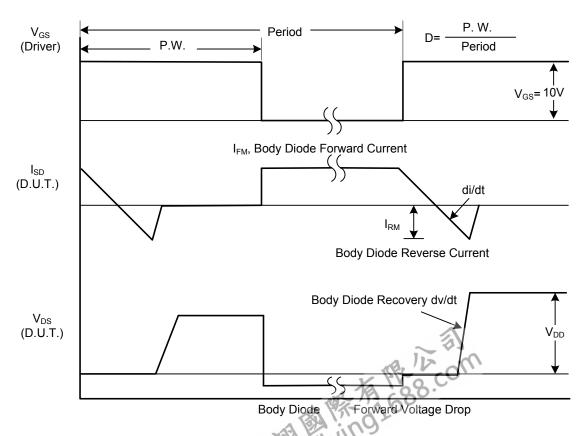


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■ TEST CIRCUITS AND WAVEFORMS



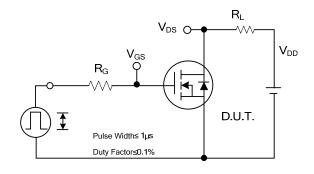
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

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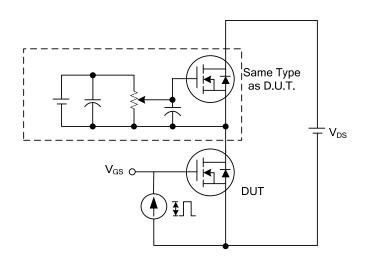
TEST CIRCUITS AND WAVEFORMS

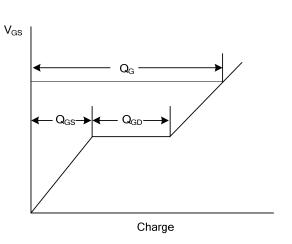


 V_{DS} 90% 10% V_{GS}

Switching Test Circuit

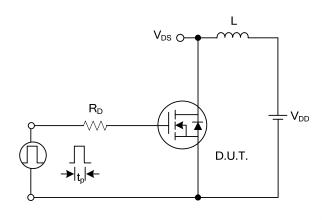
Switching Waveforms

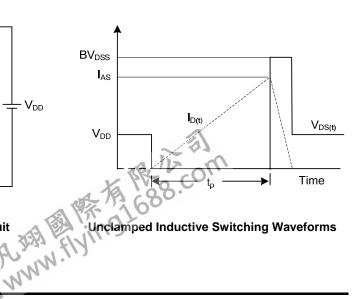




Gate Charge Test Circuit

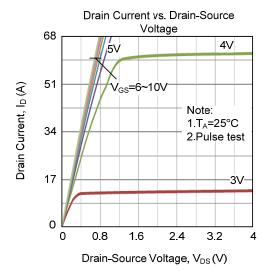
Gate Charge Waveform

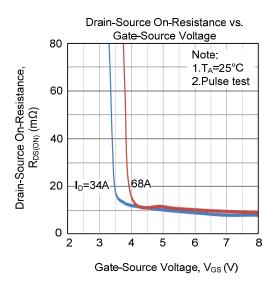


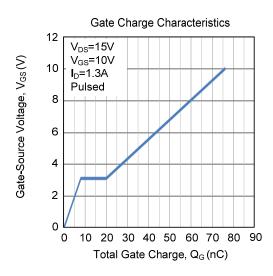


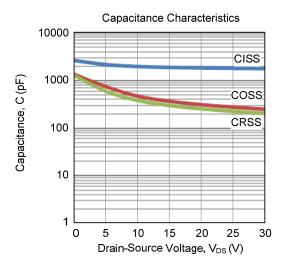
Unclamped Inductive Switching Test Circuit

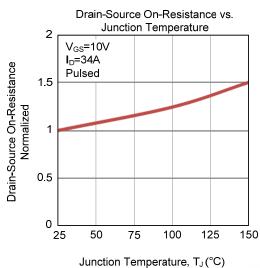
■ TYPICAL CHARACTERISTICS

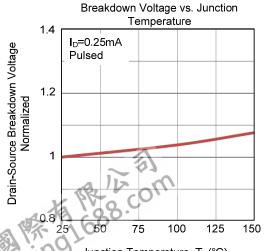




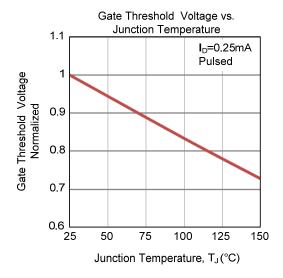


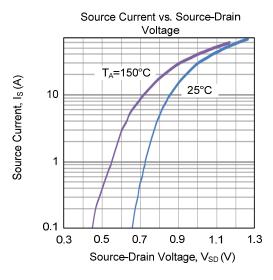


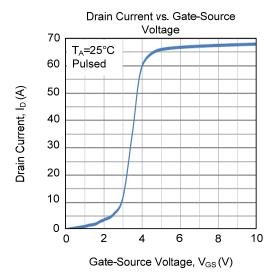


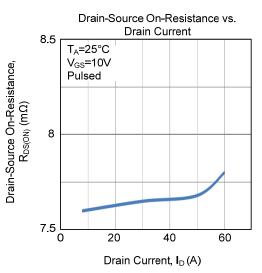


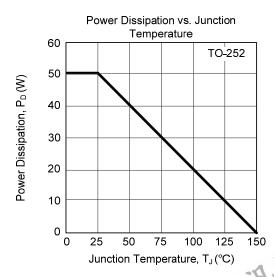
■ TYPICAL CHARACTERISTICS (Cont.)

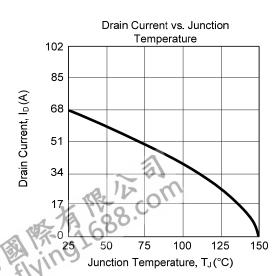




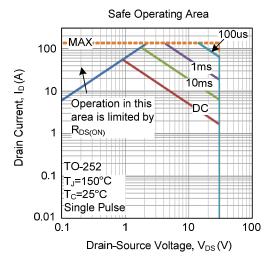








■ TYPICAL CHARACTERISTICS (Cont.)



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